

Notice of References Cited	Application/Control No. 10/651,110	Applicant(s)/Patent Under Reexamination QIAN ET AL.	
	Examiner Yuzhen Ge	Art Unit 2624	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,650,256 b2	11-2003	Kondo et al.	341/50
*	B	US-5,371,544	12-1994	Jacquin et al.	375/240.11
*	C	US-5,255,090	10-1993	Israelsen, Paul D.	375/240.12
*	D	US-6,167,156	12-2000	Antoniades et al.	382/232
*	E	US-6,546,146 b1	04-2003	Hollinger et al.	382/253
*	F	US-4,862,261	08-1989	Tanaka, Nobuyuki	348/422.1
*	G	US-6,320,907 b1	11-2001	Pau et al.	375/240.22
*	H	US-6,898,326 b2	05-2005	Washizawa, Teruyoshi	382/253
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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